FAIRCHILD

SEMICONDUCTOR®

February 2004

FDC796N

## 30V N-Channel PowerTrench® MOSFET

General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $R_{DS(ON)}$ and fast switching speed.

Applications

- DC/DC converter
- Power management
- Load switch

Features

- 12.5 A, 30 V. $R_{DS(ON)}$ = 9 mΩ @ V_{GS} = 10 V
  $R_{DS(ON)}$ = 12 mΩ @ V_{GS} = 4.5 V

- High performance trench technology for extremely low $R_{DS(ON)}$

- Low gate charge

- High power and current handling capability

- Fast switching speed.

SuperSOT-6™ FLMP

Bottom Drain
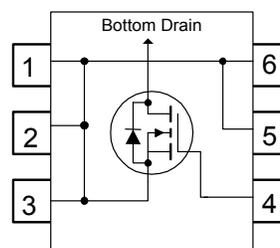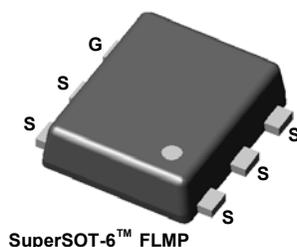
Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V_{DSS}	Drain-Source Voltage		30	V
V_{GSS}	Gate-Source Voltage		± 20	
I_D	Drain Current – Continuous	(Note 1a)	12.5	A
	– Pulsed		40	
P_D	Maximum Power Dissipation	(Note 1a)	2	W
		(Note 1b)	1.1	
T_J, T_{STG}	Operating and Storage Junction Temperature Range		−55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	60	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1b)	111	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.5	

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
.796	FDC796N	7"	8mm	3000 units

Electrical Characteristics

$T_A = 25°C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0$ V, $I_D = 250$ µA	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250$ µA, Referenced to 25°C		25		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24$ V, $V_{GS} = 0$ V			10	µA
I_{GSS}	Gate–Body Leakage	$V_{GS} = \pm 20$ V, $V_{DS} = 0$ V			±100	nA
On Characteristics (Note 2)						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250$ µA	1	2	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250$ µA, Referenced to 25°C		– 5.6		mV/°C
$R_{DS(on)}$	Static Drain–Source On Resistance	$V_{GS} = 10$ V, $I_D = 12.5$ A $V_{GS} = 4.5$ V, $I_D = 11$ A $V_{GS} = 10$ V, $I_D = 12.5$ A, T_J=125°C		7.4 9.5 9	9 12 16	mΩ
g_{FS}	Forward Transconductance	$V_{DS} = 10$ V, $I_D = 12.5$ A		48.4		S
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS} = 15$ V, $V_{GS} = 0$ V,		1444		pF
C_{oss}	Output Capacitance	f = 1.0 MHz		342		pF
C_{rss}	Reverse Transfer Capacitance			135		pF
R_G	Gate Resistance	$V_{GS} = 15$ mV, f = 1.0 MHz		1.25		Ω
Switching Characteristics (Note 2)						
$t_{d(on)}$	Turn–On Delay Time	$V_{DD} = 15$ V, $I_D = 1$ A,		10	20	ns
t_r	Turn–On Rise Time	$V_{GS} = 10$ V, $R_{GEN} = 6$ Ω		3.8	7.6	ns
$t_{d(off)}$	Turn–Off Delay Time			26	42	ns
t_f	Turn–Off Fall Time			13	23	ns
Q_g	Total Gate Charge	$V_{DS} = 15$ V, $I_D = 12.5$ A,		14	20	nC
Q_{gs}	Gate–Source Charge	$V_{GS} = 5$ V		4		nC
Q_{gd}	Gate–Drain Charge			5		nC
Drain–Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Drain–Source Diode Forward Current				1.5	A
V_{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0$ V, $I_S = 1.5$ A (Note 2)		0.73	1.2	V
t_{rr}	Diode Reverse Recovery Time	$I_F = 12.5$ A,		25		nS
Q_{rr}	Diode Reverse Recovery Charge	$d_{iF}/d_t = 100$ A/µs		15		nC

Notes: 1. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.

a)   60°C/W when mounted on a 1in² pad of 2 oz copper

b)   111°C/W when mounted on a minimum pad of 2 oz copper

Scale 1 : 1 on letter size paper
2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%
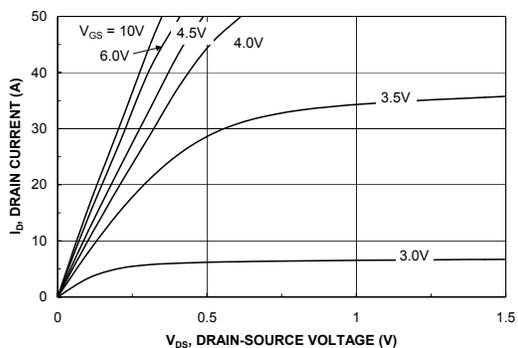
Typical Characteristics

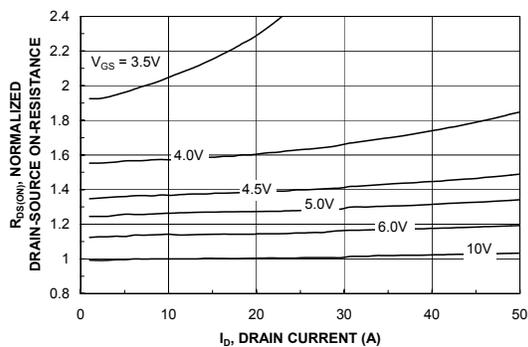
Figure 1. On-Region Characteristics.

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.
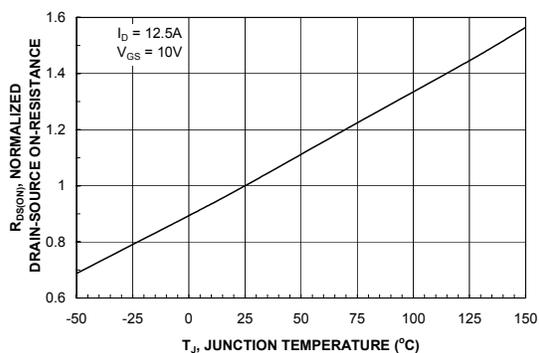

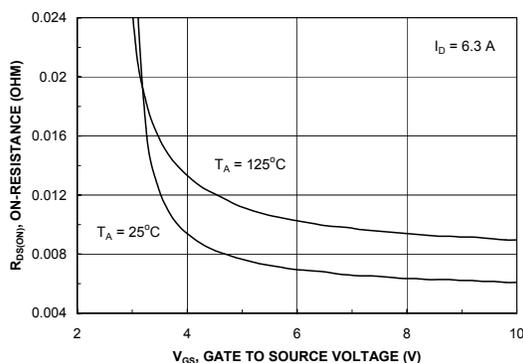**Figure 3. On-Resistance Variation with Temperature.**

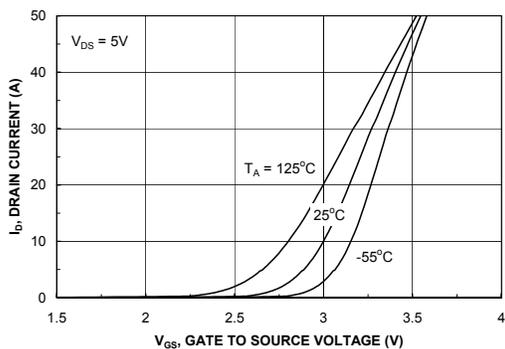**Figure 4. On-Resistance Variation with Gate-to-Source Voltage.**

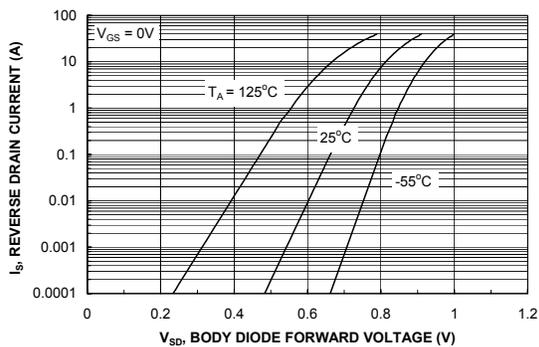**Figure 5. Transfer Characteristics.**

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.
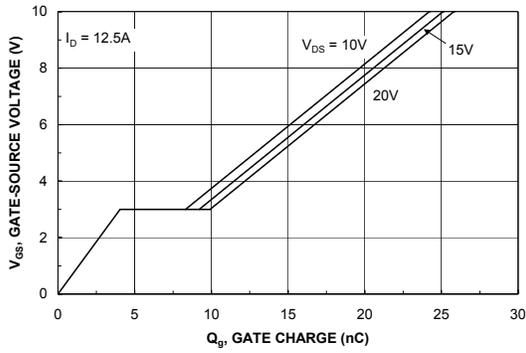
Typical Characteristics
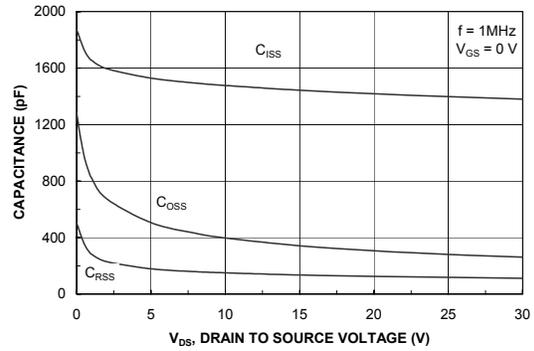

Figure 7. Gate Charge Characteristics.
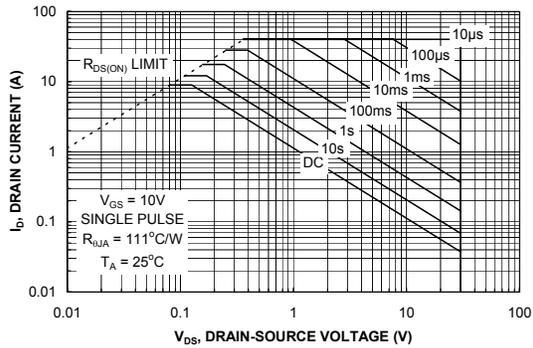

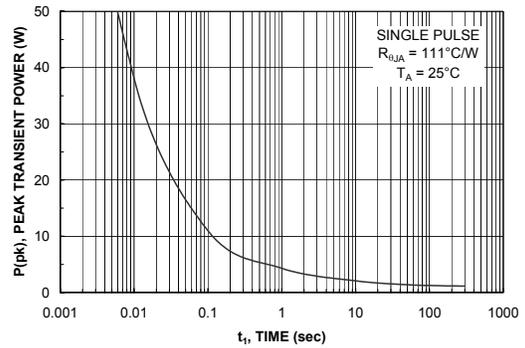Figure 8. Capacitance Characteristics.

Figure 9. Maximum Safe Operating Area.

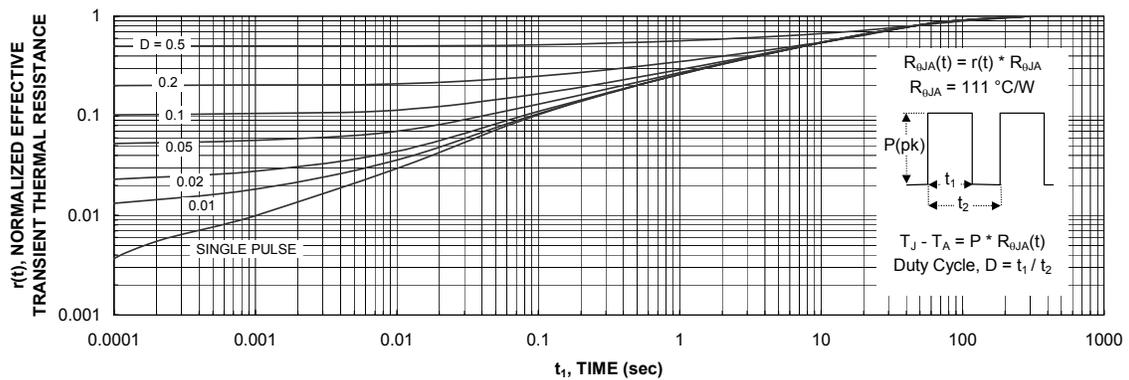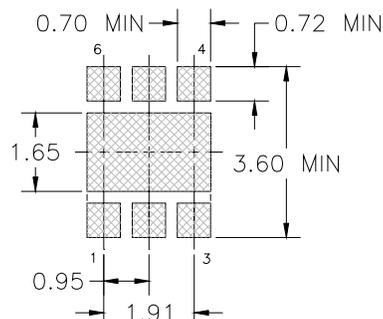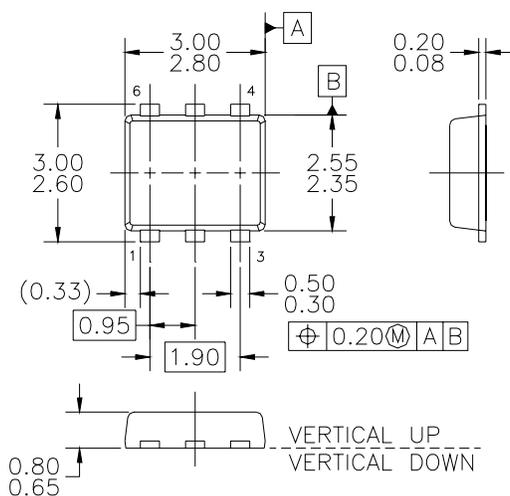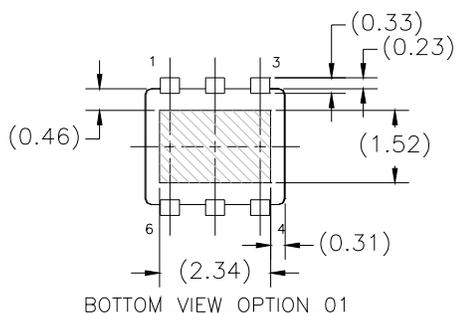Figure 10. Single Pulse Maximum Power Dissipation.

Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c.
Transient thermal response will change depending on the circuit board design.
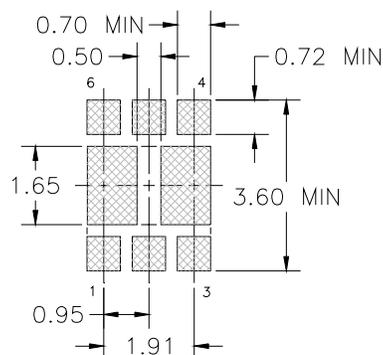
Dimensional Outline and Pad Layout

3.00
2.80

0.20
0.08

A

B

6   4

3.00
2.60

2.55
2.35

1

3

(0.33)

0.50
0.30

0.95

1.90

⊕ | 0.20Ⓜ | A | B

VERTICAL UP
VERTICAL DOWN

0.80
0.65

1   3

(0.33)
(0.23)

(0.46)

(1.52)

6   4

(0.31)

(2.34)

BOTTOM VIEW OPTION 01

1   3

(0.56)

(1.32)

(0.84)   6   4

(0.33)
(0.84)

(0.62)

BOTTOM VIEW OPTION 02

(0.42)

1   3

(0.80)

(1.30)   (0.49)

(1.01)

(1.01)   6   4

(0.33)
(0.82)

BOTTOM VIEW OPTION 03

0.70 MIN

0.72 MIN

6   4

1.65

3.60 MIN

1   3

0.95

1.91

LAND PATTERN
RECOMMENDATION
(OPTION 01)

0.70 MIN
0.50

0.72 MIN

6   4

1.65

3.60 MIN

1   3

0.95

1.91
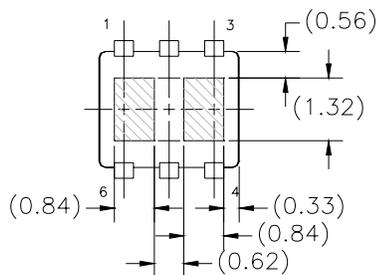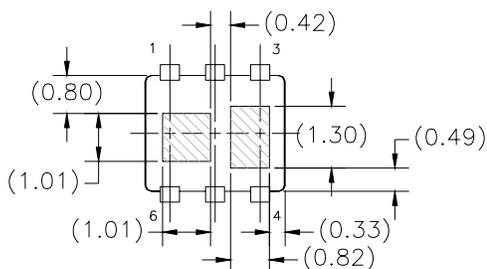
LAND PATTERN
RECOMMENDATION
(OPTION 02&03)

NOTES: UNLESS OTHERWISE SPECIFIED

A)   NO PACKAGE STANDARD REFERENCE
     AS OF MARCH, 2001.
B)   ALL DIMENSIONS ARE IN MILLIMETERS.
C)   DIMENSIONS DO NOT INCLUDE MOLD FLASH
     AND CUTTING BURRS.
D)   LEAD TIP BURR:
       HORIZONTAL: 0.20 mm MAX
       VERTICAL UP: 0.20 mm MAX
       VERTICAL DOWN: 0.05 mm MAX

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Programmable Active Droop™		PACMAN™	SPM™	

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